

INFORMATION DISCLOSURE CITATION
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Docket Number (Optional)

CHAOS1210

Application Number

10/612,175

Applicant(s)

P.H. Bryant

Filing Date

07/02/2003

Group Art Unit

2631

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
KT		6,272,209	04/22/19970	Bridger et al	379	27	08/16/1999
KT		6,275,050	08/14/2001	Born et al	324	700	11/29/1999
KT		6,519,253	02/11/2003	Posthum	370	359	02/25/1999

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

KT		United States Department of Agriculture Bulletin 1751H-501, Fundamentals of ISDN, Pages 1-26
		Conference Paper Proceedings of the 34th Meeting of IEEE Holm Conference on Electrical Contacts, 1988, IEEE Cat. No. 88CH2604-7, The Effects of Current on Stationary Contact Behavior, W.W. Bennett, Pages 267-276
KT		Physical Review B, Volume 43, Number 2, 15 January 1991-1, Degradation and Regeneration of Copper Electrical Junctions, Pages 1433-1440
		Conference Paper INTELEC, Tenth Int'l Telecommunications Energy Conference, 1988, IEEE Cat. No. 88CH2653-4, Sealing Current and Its Impact on ISDN Powering Requirements, Frantz and Taylor, Pages 151-155.

EXAMINER

/Khai Tran/

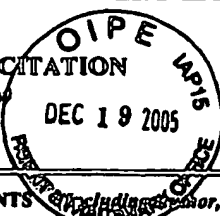
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KT

Splice-induced Impairments on Very-High-Speed Digital Data Communications Over Copper Telephone Networks, K. Sistanizadeh, Pages 3-15, UCLA Science & Engineering Library

Analysis of the Noise Environment in Future Twisted-Pair Access Technologies, Magesacher, Haar, and Zukunft, Institute for Integrated Circuits - Bridgelab, Munich, Germany, pages 1-5

KT

Standard for ISDN-Basic Access Interface for Application on the Network Side of the NT, Layer 1 Specification, Sealing Current Provisioning, S.G. Ungar, TIE1.4 Technical Subcommittee Working Group Members, pages 1-26.

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